Power MOSFET

30 V, 88 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Parameter			Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain		T _A = 25°C	I _D	17.4	Α
Current ($R_{\theta JA}$) (Note 1)		T _A = 85°C		13.5	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.65	W
Continuous Drain		T _A = 25°C	I _D	12.7	Α
Current ($R_{\theta JA}$) (Note 2)	Steady	T _A = 85°C		9.8	
Power Dissipation (R _{θJA}) (Note 2)	State	T _A = 25°C	P _D	1.41	W
Continuous Drain		T _C = 25°C	I _D	95	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		73	
Power Dissipation (R _{θJC}) (Note 1)		T _C = 25°C	P _D	79	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	175	Α
Current Limited by Pack	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Di	iode)		I _S	55	Α
Source Current (Body Di	Source Current (Body Diode) Pulsed t _p =20 μs			175	Α
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 24 A, R_G = 25 Ω)			E _{AS}	288	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

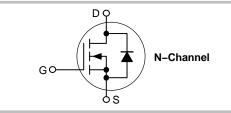
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX	
30 V	5.0 mΩ @ 10 V	88 A	
30 V	7.4 mΩ @ 4.5 V	00 A	



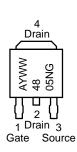


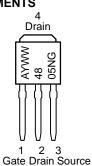




IPAK
CASE 369D
(Straight Lead DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS





A = Assembly Location*

Y = Year
WW = Work Week
4805N = Device Code
G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.9	°C/W
Junction-to-TAB (Drain)	$R_{ heta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	56.6	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	106.6	

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•		•		•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$ $V_{DS} = 24 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$				1.0 10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V				±100	nA
ON CHARACTERISTICS (Note 3)					1	I	<u>.</u>
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	l _D = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.86		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to	I _D = 30 A		4.3	5.0	mΩ
	= = (=)	11.5 V	I _D = 15 A		4.2		1
		V _{GS} = 4.5 V	I _D = 30 A		6.0	7.4	1
			I _D = 15 A		5.8		1
Forward Transconductance	9FS	V _{DS} = 15 V	, I _D = 15 A		17		S
CHARGES AND CAPACITANCES	•		•		•		<u> </u>
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			2865		pF
Output Capacitance	C _{oss}				610		
Reverse Transfer Capacitance	C _{rss}	*DS =	'- v		338		1
Total Gate Charge	Q _{G(TOT)}				20.5	26	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V,	V _{DS} = 15 V,		4.05		1
Gate-to-Source Charge	Q _{GS}	I _D = 3			8.28		1
Gate-to-Drain Charge	Q_GD				8.36		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V _D			48		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(on)}				17.2		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			20.3		
Turn-Off Delay Time	t _{d(off)}				20.8		
Fall Time	t _f				8.0		1
Turn-On Delay Time	t _{d(on)}				10.8		ns
Rise Time	t _r	V_{GS} = 11.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			20.5		1
Turn-Off Delay Time	t _{d(off)}				30.8		1
Fall Time	t _f				4.4		

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V_{SD} $V_{GS} = 0 V$,	T _J = 25°C		0.87	1.2	V
		I _S = 30 A	T _J = 125°C		0.76		
Reverse Recovery Time	t _{RR}		•		25.7		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			13.1		
Discharge Time	tb				12.6		
Reverse Recovery Time	Q_{RR}				18		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nΗ
Drain Inductance, DPAK	L _D	1			0.0164		
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		
Gate Inductance	L _G				3.46		
Gate Resistance	R_{G}	1			0.8		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width $\leq 300~\mu s$, Duty Cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

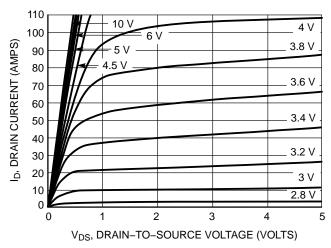


Figure 1. On-Region Characteristics

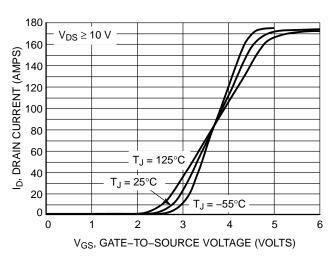


Figure 2. Transfer Characteristics

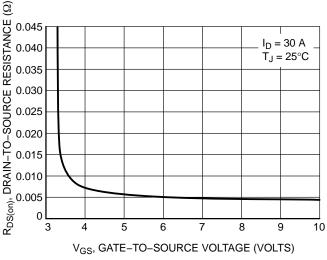


Figure 3. On–Resistance vs. Gate–to–Source Voltage

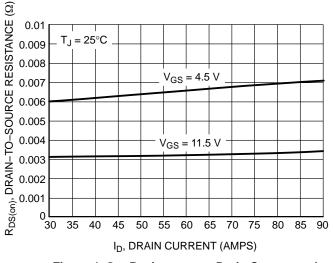


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

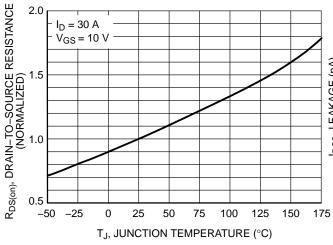


Figure 5. On–Resistance Variation with Temperature

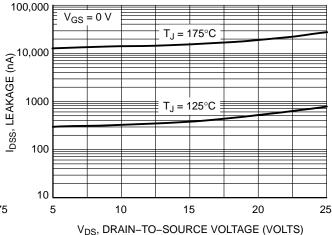
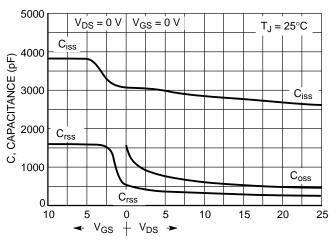


Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 8. Gate-1

100

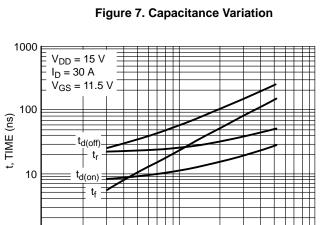


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

10

R_G, GATE RESISTANCE (OHMS)

1

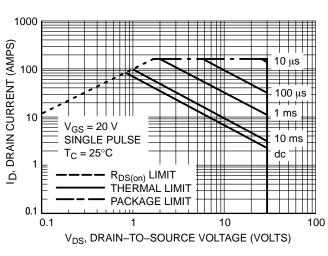


Figure 11. Maximum Rated Forward Biased Safe Operating Area

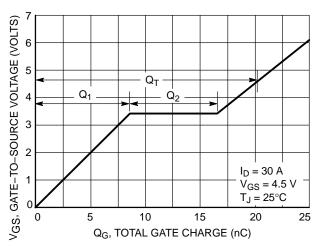


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

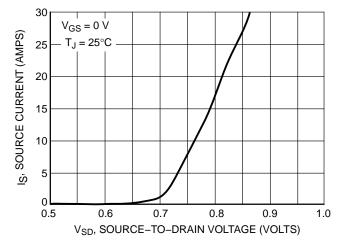


Figure 10. Diode Forward Voltage vs. Current

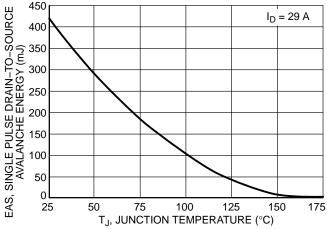


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

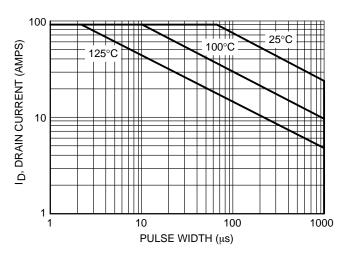


Figure 13. Avalanche Characteristics

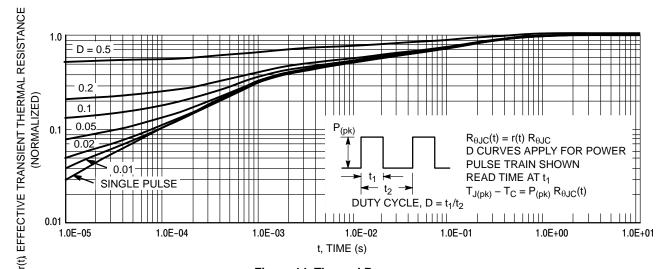


Figure 14. Thermal Response

ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4805NT4G	DPAK (Pb-Free)	2,500 / Tape & Reel
NTD4805N-1G	IPAK (Pb-Free)	75 Units / Rail
NVD4805NT4G*	DPAK (Pb-Free)	2,500 / Tape & Reel

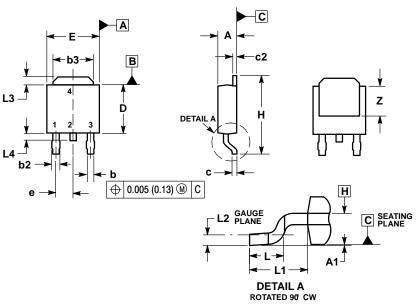
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIMETERS		
DIM	MIN MAX		MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74	REF	
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*

6.20 3.00 0.244 0.118 2.58 0.102 5.80 1.60 6.17 0.228 0.063 0.243

 $\left(\frac{mm}{inches}\right)$ SCALE 3:1

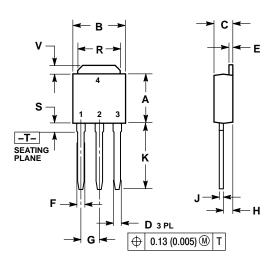
STYLE 2:

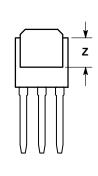
PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

IPAK CASE 369D **ISSUE C**





NOTES

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN MAX		MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
Κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2:

PIN 1. GATE 2.

- DRAIN SOURCE 3.
- DRAIN

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